

Sonda de teste TIC SF-PA100-J (L38.8)

Material e acabamentos

Êmbolo: Bronze ou Latão ou BeCu, banhado a ouro ou níquel;

Tambor: Latão, banhado a ouro ou niquelado;

Mola: Aço inoxidável ou fio de música;

As fotos

- Todas as dicas que poderíamos fornecer para você
- Se você estiver interessado, pls entre em contato comigo

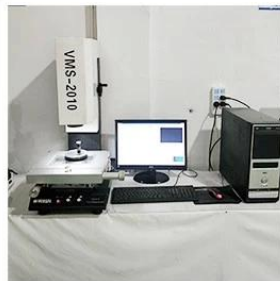


Spring loaded pin (single) for PCB, ICT, FCT testing etc;
Pogo pin (connector) to establish connection between two printed circuit boards for charging, locating, Battery, Semiconductor & Interconnect applications;
Double ended probe for BGA and Semiconductor testing;
Universal pin without spring, coating pin, LM pin with QZ and VZ series;
High current probe, Switch probe, Capacitance needle;
Terminal & receptacle /socket;
Other related electronic components, 30# OK wire, Jig locks, POM, Iron hinge etc

Controle de equipamentos de teste



1. Agilent current testing



2. Quadratic element



3. Load Curve Meter



4. Bond Test



5. Life Fatigue Test



6. Microscope

Embalagem e expedição

Standard products will be delivered out within 3 days. Customized products will be sent out within 15 days.

